Substitute for form 1449A/PTO & 14498/PTO Complete if Known 10/627,863 **FIRST Application Number INFORMATION DISCLOSURE** Filing Dat July 28, 2003 STATEMENT BY APPLICANT First Named Inv nt r David K ith BOWEN et al. Examin r Name Unassigned (use as many sheets as necessary) 1 Of Att rney D cket Numb r 032516-004

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JIL	Petre, Rob, "Physics of X-ray Imaging", July 24, 2002, 1 page.				
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Examiner Signature	Muer	1- Must	Date Considered	6/18/04
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*EXAMINER: Injural reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.